Mechanism of Site-Specific Ion Desorption from Core-Excited PMMA Thin Film

<u>S. Wada¹</u>, E. O. Sako¹, E. Ikenaga², K. Isari¹, K. Kudara¹, K. Mase³, T. Sekitani¹ and K. Tanaka¹

¹Department of Physical Science, Hiroshima University, Higashi-Hiroshima 739-8526, JAPAN ²Hiroshima Synchrotron Radiation Center, Hiroshima University, Higashi-Hiroshima 739-8526, JAPAN

³Institute of Materials Structure Science, Tsukuba 305-0801, JAPAN

Core-excitation takes place within quite local area, so a specific atom in a molecule can be excited resonantly. Using tunable synchrotron radiation, site-selective core excitation can be achieved and site-selective bond braking is expected in the vicinity of the atom where the primary core excitation takes place. This suggests the possibility that the resonant excitation by soft x-ray can control chemical bond scission selectively. Recently, the mechanism of site-specific photon stimulated ion desorption (PSID) of PMMA has been studied in detail by using an Auger electron - photoion coincidence spectroscopy and ab initio MO calculations[1,2]. In the case of C 1s excitation, CH_n^+ (n=1-3) ions are desorbed efficiently in the excitation to the O-CH₃ anti-bonding orbital. Moreover, in this excitation, it was revealed that desorbed CH_3^+ and CH_2^+ ions are mainly produced via a Auger final states with hole(s) in O-CH₃ bonding orbitals. It was found that site-specific PSID by core-excitation is promoted by the decline of bonding due to attachment of electron to anti-bonding orbital and the Coulomb repulsion due to removal of electrons from bonding orbitals, and the possibility of controlling the scission of chemical bonds is discussed.

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